



TXS0108E-Q1面向开漏和推挽应用的 8 位双向电压电平转换 转换器

1 特性

- 符合汽车类应用的 AEC-Q100 标准
 - 器件温度等级 1: -40°C 至 125°C
 - 器件人体放电模式 (HBM) 静电放电 (ESD) 分类等级 2
 - 器件组件充电模式 (CDM) ESD 分类等级 C6
- 无需方向控制信号
- 最大数据速率
 - 110Mbps (推挽)
 - 1.2Mbps (开漏)
- A 端口 1.4V 至 3.6V; B 端口 1.65V 至 5.5V ($V_{CCA} \leq V_{CCB}$)
- 无需电源排序 - V_{CCA} 或 V_{CCB} 均可优先斜升
- 锁断性能超过 100mA, 符合 JESD 78 II 类规范的要求
- 静电放电 (ESD) 保护性能超过 JESD 22 规范的要求 (A 端口)
 - 2000V 人体放电模式 (A114-B)
 - 1000V 充电器件模型 (C101)
- IEC 61000-4-2 ESD (B 端口)
 - ±8kV 接触放电
 - ±6kV 气隙放电

2 应用

- 汽车

3 说明

这款 8 位非反向转换器使用两个独立的可配置电源轨。A 端口跟踪 V_{CCA} 引脚的电源电压。 V_{CCA} 引脚可接受 1.4V 到 3.6V 范围内的任意电源电压。B 端口跟踪 V_{CCB} 引脚的电源电压。 V_{CCB} 引脚可接受 1.65V 到 5.5V 范围内的任意电源电压。这两个输入电源引脚可实现 1.5V、1.8V、2.5V、3.3V 和 5V 电压节点之间的任意低压双向转换。

输出使能 (OE) 输入为低电平时, 所有输出均将置于高阻抗 (Hi-Z) 状态。

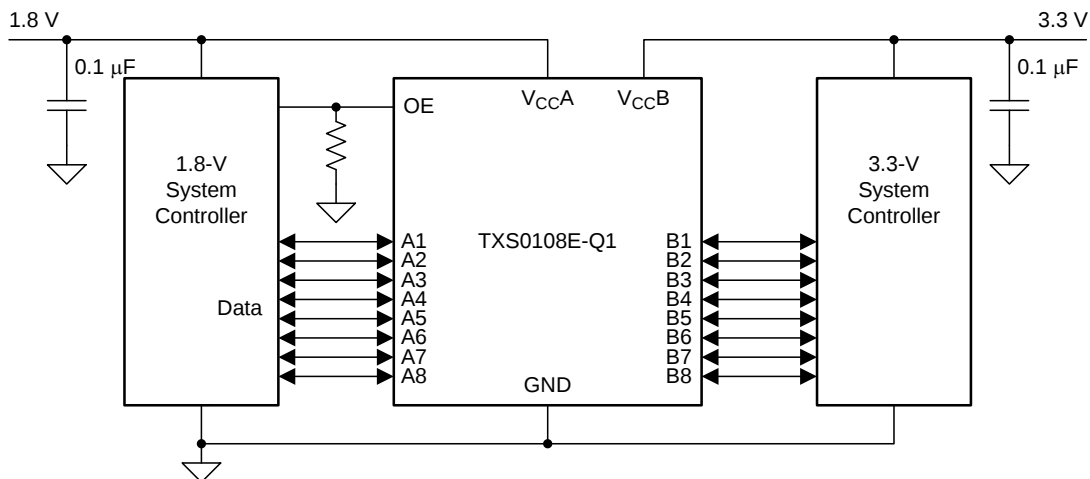
为确保输出在上电或断电期间处于 Hi-Z 状态, 需通过一个下拉电阻将 OE 接至 GND。该电阻的最小值取决于驱动器的拉电流能力。

器件信息⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
TXS0108E-Q1	TSSOP (20)	6.50mm x 6.40mm

(1) 如需了解所有可用封装, 请参见数据表末尾的可订购产品附录。

简化应用



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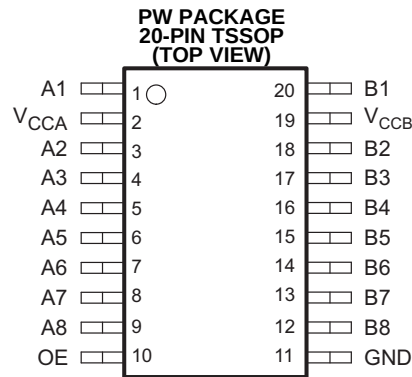
4 修订历史记录

Changes from Original (June 2015) to Revision A

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• 已更改引脚功能	1
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5 Pin Configuration and Functions



Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
A1	1	I/O	Input/output 1. Referenced to V _{CCA}
A2	3	I/O	Input/output 2. Referenced to V _{CCA}
A3	4	I/O	Input/output 3. Referenced to V _{CCA}
A4	5	I/O	Input/output 4. Referenced to V _{CCA}
A5	6	I/O	Input/output 5. Referenced to V _{CCA}
A6	7	I/O	Input/output 6. Referenced to V _{CCA}
A7	8	I/O	Input/output 7. Referenced to V _{CCA}
A8	9	I/O	Input/output 8. Referenced to V _{CCA}
B1	20	I/O	Input/output 1. Referenced to V _{CCB}
B2	18	I/O	Input/output 2. Referenced to V _{CCB}
B3	17	I/O	Input/output 3. Referenced to V _{CCB}
B4	16	I/O	Input/output 4. Referenced to V _{CCB}
B5	15	I/O	Input/output 5. Referenced to V _{CCB}
B6	14	I/O	Input/output 6. Referenced to V _{CCB}
B7	13	I/O	Input/output 7. Referenced to V _{CCB}
B8	12	I/O	Input/output 8. Referenced to V _{CCB}
GND	11	G	Ground
OE	10	I	3-state output-mode enable. Pull OE low to place all outputs in 3-state mode. Referenced to V _{CCA} .
V _{CCA}	2	I	A-port supply voltage. 1.5 V ≤ V _{CCA} ≤ 3.6 V, V _{CCA} ≤ V _{CCB} .
V _{CCB}	19	I	B-port supply voltage. 1.65 V ≤ V _{CCB} ≤ 5.5 V.

(1) I = Input, O = Output, I/O = Bi-directional, G = Ground

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CCA}	Supply voltage		–0.5	4.6	V
V _{CCB}			–0.5	5.5	V
V _I	Input voltage ⁽²⁾	A port	–0.5	4.6	V
		B port	–0.5	6.5	
V _O	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾	A port	–0.5	4.6	V
		B port	–0.5	6.5	
V _O	Voltage range applied to any output in the high or low state ^{(2) (3)}	A port	–0.5	V _{CCA} + 0.5	V
		B port	–0.5	V _{CCB} + 0.5	
I _{IK}	Input clamp current	V _I < 0		–50	mA
I _{OK}	Output clamp current	V _O < 0		–50	mA
I _O	Continuous output current		–50	50	mA
	Continuous current through V _{CCA} , V _{CCB} , or GND		–100	100	mA
T _{stg}	Storage temperature		–65	150	°C

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Conditions](#) is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output negative Voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) The value of V_{CCA} and V_{CCB} are provided in the recommended operating conditions table.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per AEC Q100-011	±1000	

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾⁽²⁾

			V _{CCA} (V)	V _{CCB} (V)	MIN	MAX	UNIT
V _{CCA}	Supply voltage ⁽³⁾				1.4	3.6	V
V _{CCB}					1.65	5.5	
V _{IH}	High-level input voltage	A-Port I/Os	1.4 to 1.95	1.65 to 5.5	V _{CCI} – 0.2	V _{CCI}	V
			1.95 to 3.6		V _{CCI} – 0.4	V _{CCI}	
		B-Port I/Os	1.4 to 3.6		V _{CCI} – 0.4	V _{CCI}	
		OE			V _{CCA} × 0.65	5.5	
V _{IL}	Low-level input voltage	A-Port I/Os	1.4 to 1.95		0	0.15	V
			1.95 to 3.6		0	0.15	
		B-Port I/Os	1.4 to 3.6		0	0.15	
		OE			0	V _{CCA} × 0.35	
Δt/Δv	Input transition rise or fall rate	A-Port I/Os Push-pull	1.4 to 3.6		10		ns/V
		B-Port I/Os Push-pull					
		Control input					
T _A	Operating free-air temperature				–40	125	°C

(1) V_{CCI} is the V_{CC} associated with the data input port.

(2) V_{CCO} is the V_{CC} associated with the output port.

(3) V_{CCA} must be less than or equal to V_{CCB}, and V_{CCA} must not exceed 3.6 V.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TXS0108E-Q1	UNIT
		PW (TSSOP)	
		20 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	101.5	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	35.9	
R _{θJB}	Junction-to-board thermal resistance	52.4	
ψ _{JT}	Junction-to-top characterization parameter	2.3	
ψ _{JB}	Junction-to-board characterization parameter	51.9	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	—	

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Electrical Characteristics⁽¹⁾⁽²⁾⁽³⁾

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CCA} (V)	V _{CCB} (V)	T _A = 25°C			T _A = –40°C to 125°C		UNIT
					MIN	TYP	MAX	MIN	MAX	
V _{OHA}		I _{OH} = –20 μA, V _{IB} ≥ V _{CCB} – 0.4 V	1.4 to 3.6	1.65 to 5.5				V _{CCA} × 0.67		V
V _{OLA}		I _{OL} = 180 μA, V _{IB} ≤ 0.15 V	1.4	1.65 to 5.5					0.4	V
		I _{OL} = 220 μA, V _{IB} ≤ 0.15 V	1.65						0.4	
		I _{OL} = 300 μA, V _{IB} ≤ 0.15 V	2.3						0.4	
		I _{OL} = 400 μA, V _{IB} ≤ 0.15 V	3						0.55	
V _{OHB}		I _{OH} = –20 μA, V _{IA} ≥ V _{CCA} – 0.2 V	1.4 to 3.6	1.65 to 5.5				V _{CCB} × 0.67		V
V _{OLB}		I _{OL} = 220 μA, V _{IA} ≤ 0.15 V	1.4 to 3.6	1.65					0.4	V
		I _{OL} = 300 μA, V _{IA} ≤ 0.15 V		2.3					0.4	
		I _{OL} = 400 μA, V _{IA} ≤ 0.15 V		3					0.55	
		I _{OL} = 620 μA, V _{IA} ≤ 0.15 V		4.5					0.55	
I _I	OE	V _I = V _{CCI} or GND	1.4	1.65 to 5.5	–1		1		2	μA
I _{OZ}	A or B port		1.4	1.65 to 5.5	–1		1	–2	2	μA
I _{CCA}		V _I = V _O = Open, I _O = 0	1.4 to 3.6	2.3 to 5.5					2	μA
			3.6	0					2	
			0	5.5					–1	
I _{CCB}		V _I = V _O = Open, I _O = 0	1.4 to 3.6	2.3 to 5.5					6	μA
			3.6	0					–1	
			0	5.5					1.5	
I _{CCA} + I _{CCB}		V _I = V _{CCI} or GND, I _O = 0	1.4 to 3.6	2.3 to 5.5					8	μA
I _{CCZA}		V _I = V _O = Open, I _O = 0, OE = GND	1.4 to 3.6	1.65 to 5.5					2	μA
I _{CCZB}		V _I = V _O = Open, I _O = 0, OE = GND	1.4 to 3.6	1.65 to 5.5					6	μA
C _i	OE		3.3	3.3		4.5		6.75		pF
C _{io}	A port		3.3	3.3		6		7.6		pF
	B port					5.5		6.9		

- (1) V_{CCO} is the V_{CC} associated with the output port.
 (2) V_{CCI} is the V_{CC} associated with the input port.
 (3) V_{CCA} must be less than or equal to V_{CCB}, and V_{CCA} must not exceed 3.6 V.

6.6 Timing Requirements: V_{CCA} = 1.5 V ± 0.1 V

 over recommended operating free-air temperature range, V_{CCA} = 1.5 V ± 0.1 V (unless otherwise noted)

				V _{CC B} = 1.8 V ± 0.15 V		V _{CC B} = 2.5 V ± 0.2 V		V _{CC B} = 3.3 V ± 0.3 V		V _{CC B} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Data rate	Push-pull			40		60		60		60		Mbps
	Open-drain			0.8		0.8		1		1		
t _w	Pulse duration	Push-pull	Data inputs	25		16.7		16.7		16.7		ns
	Pulse duration	Open-drain		1250		1250		1000		1000		

6.7 Timing Requirements: $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.8\text{ V} \pm 0.15\text{ V}$ (unless otherwise noted)

				$V_{CC\ B} = 1.8\ V$ $\pm 0.15\ V$	$V_{CC\ B} = 2.5\ V$ $\pm 0.2\ V$	$V_{CC\ B} = 3.3\ V$ $\pm 0.3\ V$	$V_{CC\ B} = 5\ V$ $\pm 0.5\ V$	UNIT	
				MIN	MAX	MIN	MAX		MIN
	Data rate	Push-pull		45	65	70	70	Mbps	
		Open-drain		0.8	0.8	0.8	1		
t_w	Pulse duration	Push-pull		22.2	15.3	15.3	15.3	ns	
		Open-drain		1250	1250	1250	1000		

6.8 Timing Requirements: $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

				$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CC} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
	Data rate	Push-pull		80		95		100	Mbps	
		Open-drain		0.8		0.8		1		
t_w	Pulse duration	Push-pull	Data inputs	12.5		10.5		10	ns	
		Open-drain		1250		1250		1000		

6.9 Timing Requirements: $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 3.3\text{ V} \pm 0.3\text{ V}$ (unless otherwise noted)

				$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CC} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	
	Data rate	Push-pull		100		110		Mbps
		Open-drain		0.8		1.2		
t_w	Pulse duration	Push-pull	Data inputs	10		9.1		ns
		Open-drain		1250		833		

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6.10 Switching Characteristics: $V_{CCA} = 1.5 \text{ V} \pm 0.1 \text{ V}$

 over recommended operating free-air temperature range, $V_{CCA} = 1.5 \text{ V} \pm 0.1 \text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION (DRIVING)	V _{CCB} = 1.8 V ± 0.15 V		V _{CCB} = 2.5 V ± 0.2 V		V _{CCB} = 3.3 V ± 0.3 V		V _{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PHL}	A	B	Push-pull		11		9.2		8.6		8.6	ns
t _{PLH}			Open-drain	2.5	14.4	2	12.8	2	12.2	1.9	12	
			Push-pull		12		10		9.8		9.7	
			Open-drain	0.9	720	0.9	554	1	473	1.5	384	
t _{PHL}	B	A	Push-pull		12.7		11.1		11		12	ns
t _{PLH}			Open-drain	3.4	13.2	2.6	9.6	2.3	8.5	2	7.5	
			Push-pull		9.5		6.2		5.1		4.2	
			Open-drain		745		603		519		407	
t _{en}	OE	A or B	Push-pull		480		480		480		480	ns
t _{dis}	OE	A or B			400		400		400		400	ns
t _{rA}	A-port rise time		Push-pull	3	13.1	2.4	9.8	2	9	2	8.9	ns
			Open-drain	220	982	180	716	140	592	100	481	
t _{rB}	B-port rise time		Push-pull	2.6	11.4	1.6	7.4	1	6	0.7	5	ns
			Open-drain	220	1020	150	756	100	653	40	370	
t _{fA}	A-port fall time		Push-pull	2.3	9.9	1.7	7.7	1.6	6.8	1.7	6	ns
			Open-drain	2.4	10	1.8	8.2	1.7	9	1.5	9.15	
t _{fB}	B-port fall time		Push-pull	2	8.7	1.3	5.5	1	3.8	1	3.1	
			Open-drain	2	11.5	1.3	8.6	1	9.6	1	7.7	
t _{SK(O)}	Channel-to-channel skew		Push-pull		1		1		1		1	ns

6.11 Switching Characteristics: $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION (DRIVING)	V _{CCB} = 1.8 V ± 0.15 V		V _{CCB} = 2.5 V ± 0.2 V		V _{CCB} = 3.3 V ± 0.3 V		V _{CCB} = 5 V ± 0.5 V		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PHL}	A	B	Push-pull	8.2		6.4		5.7		5.6		ns
t _{PLH}			Open-drain	2.1	11.4	1.7	9.9	1.6	9.3	1.5	8.9	
			Push-pull	9		5.6		6.5		6.3		
			Open-drain	0.15	729	0.2	584	0.3	466	0.3	346	
t _{PHL}	B	A	Push-pull	9.8		8		7.4		7		ns
t _{PLH}			Open-drain	3.19	12.1	2	8.5	1.9	7.3	1.8	6.2	
			Push-pull	10.2		7		5.8		5		
			Open-drain	733		578		459		323		
t _{en}	OE	A or B	Push-pull	100		100		100		100		ns
t _{dis}	OE	A or B		410		410		410		410		ns
t _{rA}	A-port rise time		Push-pull	2.7	11.9	2	8.6	1.9	7.8	1.8	7.4	ns
			Open-drain	250	996	200	691	150	508	110	365	
t _{rB}	B-port rise time		Push-pull	2.5	10.5	1.7	7.4	1.1	5.3	60	4.7	ns
			Open-drain	250	1001	170	677	120	546	32	323	
t _{fA}	A-port fall time		Push-pull	2.1	8.8	1.6	7.1	1.4	6.8	1.4	6.06	ns
			Open-drain	2.2	9	1.7	7.2	1.4	6.8	1.2	6.1	
t _{fB}	B-port fall time		Push-pull	2	8.3	1.3	5.4	0.9	3.9	0.7	3	
			Open-drain	2	10.5	1	10.7	1	9.6	0.6	7.8	
t _{SK(O)}	Channel-to-channel skew		Push-pull	1		1		1		1		ns

6.12 Switching Characteristics: $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 2.5\text{ V} \pm 0.2\text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION (DRIVING)	$V_{CCB} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CCB} = 3.3\text{ V} \pm 0.3\text{ V}$		$V_{CCB} = 5\text{ V} \pm 0.5\text{ V}$		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull		5		4		3.7	ns
			Open-drain		6.2		6.3		5.8	
t_{PLH}			Push-pull		5.2		4.3		3.9	
			Open-drain		5		17.5		15.5	
t_{PHL}	B	A	Push-pull		5.4		4.7		4.2	ns
			Open-drain		7.3		6		4.9	
t_{PLH}			Push-pull		5.9		4.4		3.5	
			Open-drain		5		5		5	
t_{en}	OE	A or B	Push-pull		100		100		100	ns
t_{dis}	OE	A or B			400		400		400	ns
t_{rA}	A-port rise time		Push-pull	1.89	7.3	1.6	6.4	1.5	5.8	ns
			Open-drain	110.00	692	157	529	116	377	
t_{rB}	B-port rise time		Push-pull	1.70	6.5	1.3	5.1	0.9	4.32	ns
			Open-drain	107.00	693	140	483	77	304	
t_{fA}	A-port fall time		Push-pull	1.50	5.7	1.2	4.7	1.3	3.8	ns
			Open-drain	1.50	5.6	1.2	4.7	1.1	4.2	
t_{fB}	B-port fall time		Push-pull	1.40	5.4	0.9	4.1	0.7	3	
			Open-drain	0.40	14.2	0.5	19.4	0.4	3	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull		1		1		1	ns

6.13 Switching Characteristics: $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range, $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION (DRIVING)	$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$		$V_{CCB} = 5 \text{ V} \pm 0.5 \text{ V}$		UNIT
				MIN	MAX	MIN	MAX	
t_{PHL}	A	B	Push-pull		3.8		3.28	ns
			Open-drain		5.3		4.8	
t_{PLH}			Push-pull		3.9		3.5	
			Open-drain		5		12.5	
t_{PHL}	B	A	Push-pull		4.2		3.8	ns
			Open-drain		5.5		4.5	
t_{PLH}			Push-pull		4.32		4.3	
			Open-drain		5		5	
t_{en}	OE	A or B	Push-pull		100		100	ns
t_{dis}	OE	A or B			400		400	ns
t_{rA}	A-port rise time		Push-pull	1.5	5.7	1.4	5	ns
			Open-drain	129	446	99.6	337	
t_{rB}	B-port rise time		Push-pull	1.35	5	1	4.24	ns
			Open-drain	129	427	77	290	
t_{fA}	A-port fall time		Push-pull	1.4	4.5	1.3	3.5	ns
			Open-drain	1.4	4.4	1.2	3.7	
t_{fB}	B-port fall time		Push-pull	1.3	4.2	1.1	3.1	
			Open-drain	1.3	4.2	1.1	3.1	
$t_{SK(O)}$	Channel-to-channel skew		Push-pull		1		1	ns

6.14 Typical Characteristics

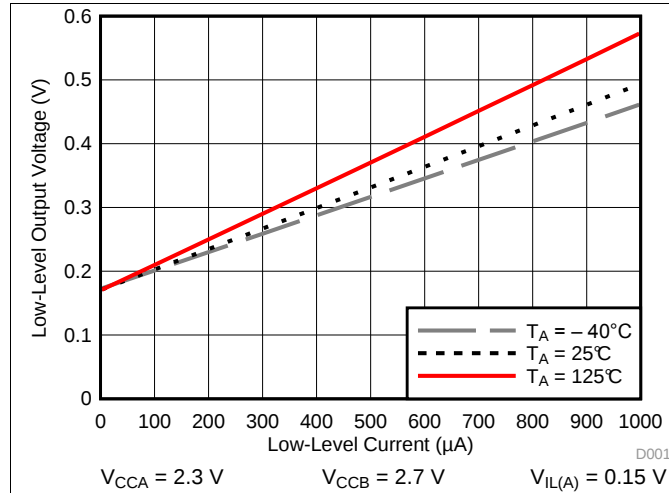


Figure 1. Low-Level Output Voltage ($V_{OL(Bx)}$) vs Low-Level Current ($I_{OL(Bx)}$)

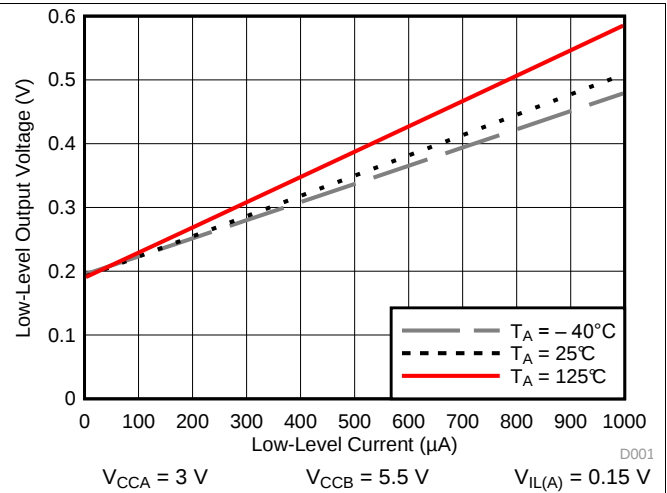


Figure 2. Low-Level Output Voltage ($V_{OL(Bx)}$) vs Low-Level Current ($I_{OL(Bx)}$)

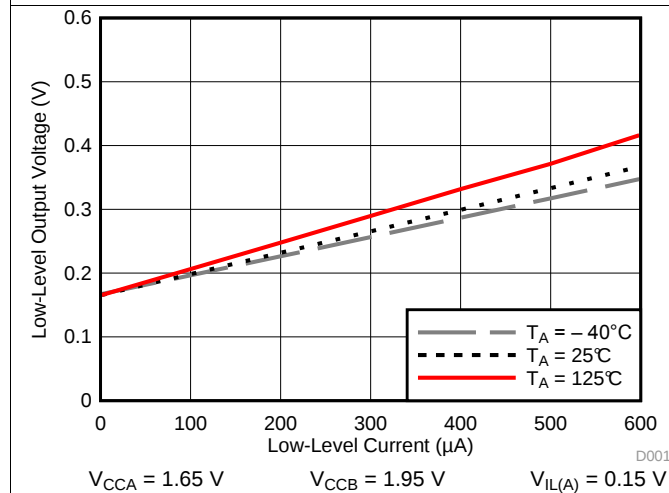


Figure 3. Low-Level Output Voltage ($V_{OL(Bx)}$) vs Low-Level Current ($I_{OL(Bx)}$)

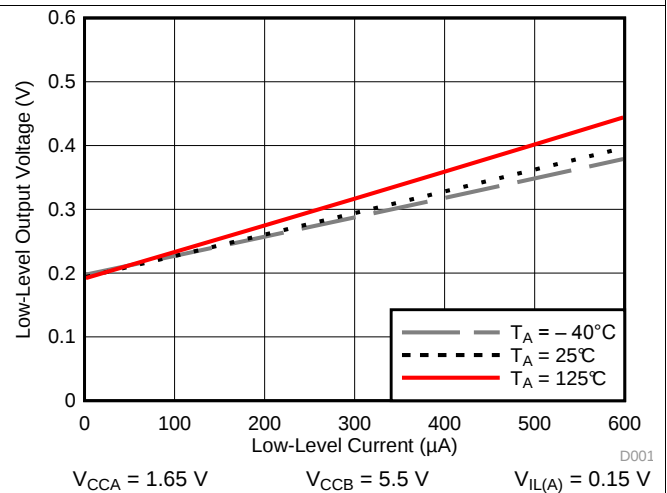


Figure 4. Low-Level Output Voltage ($V_{OL(Bx)}$) vs Low-Level Current ($I_{OL(Bx)}$)

7 Parameter Measurement Information

7.1 Load Circuits

Figure 5 shows the push-pull driver circuit used for measuring data rate, pulse duration, propagation delay, output rise-time and fall-time. Figure 6 shows the open-drain driver circuit used for measuring data rate, pulse duration, propagation delay, output rise-time and fall-time.

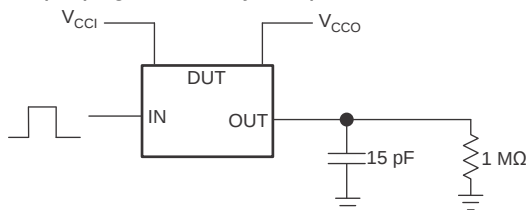


Figure 5. Data Rate, Pulse Duration, Propagation Delay, Output Rise-Time and Fall-Time Measurement Using a Push-Pull Driver

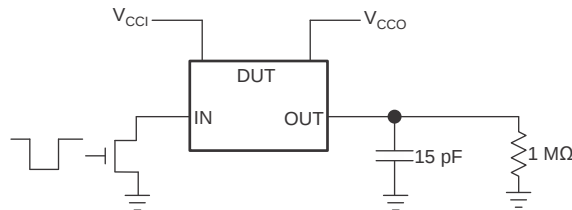
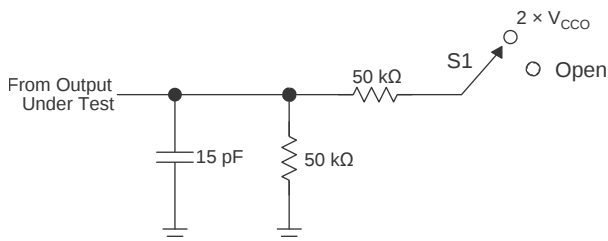


Figure 6. Data Rate (10 pF), Pulse Duration (10 pF), Propagation Delay, Output Rise-Time and Fall-Time Measurement Using an Open-Drain Driver



TEST	S1
t_{PZL} / t_{PLZ} (t_{dis})	$2 \times V_{CCO}$
t_{PHZ} / t_{PZH} (t_{en})	Open

Figure 7. Load Circuit for Enable-Time and Disable-Time Measurement

1. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
2. t_{PZL} and t_{PZH} are the same as t_{en} .
3. V_{CCI} is the V_{CC} associated with the input port.
4. V_{CCO} is the V_{CC} associated with the output port.

7.2 Voltage Waveforms

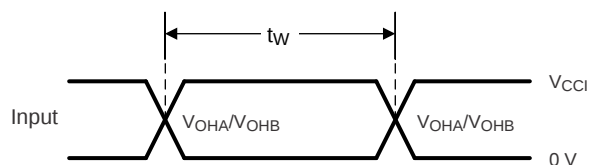


Figure 8. Pulse Duration (Push-Pull)

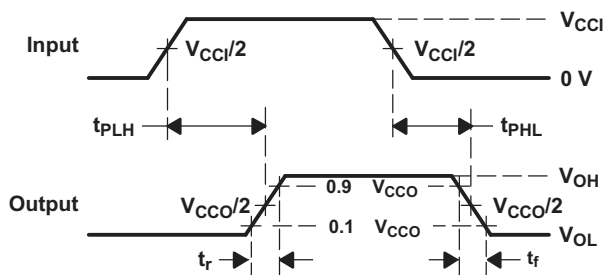


Figure 9. Propagation Delay Times

- C_L includes probe and jig capacitance.
- Waveform 1 in Figure 10 is for an output with internal such that the output is high, except when OE is high (see Figure 7). Waveform 2 in Figure 10 is for an output with conditions such that the output is low, except when OE is high.
- All input pulses are supplied by generators having the following characteristics: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $dv/dt \geq 1 \text{ V/ns}$.
- The outputs are measured one at a time, with one transition per measurement.
- t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- t_{PZL} and t_{PZH} are the same as t_{en} .
- t_{PLH} and t_{PHL} are the same as t_{pd} .
- V_{CCI} is the V_{CC} associated with the input port.
- V_{CCO} is the V_{CC} associated with the output port.

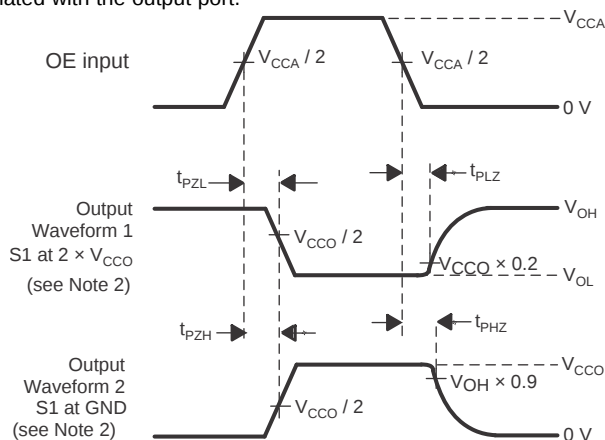


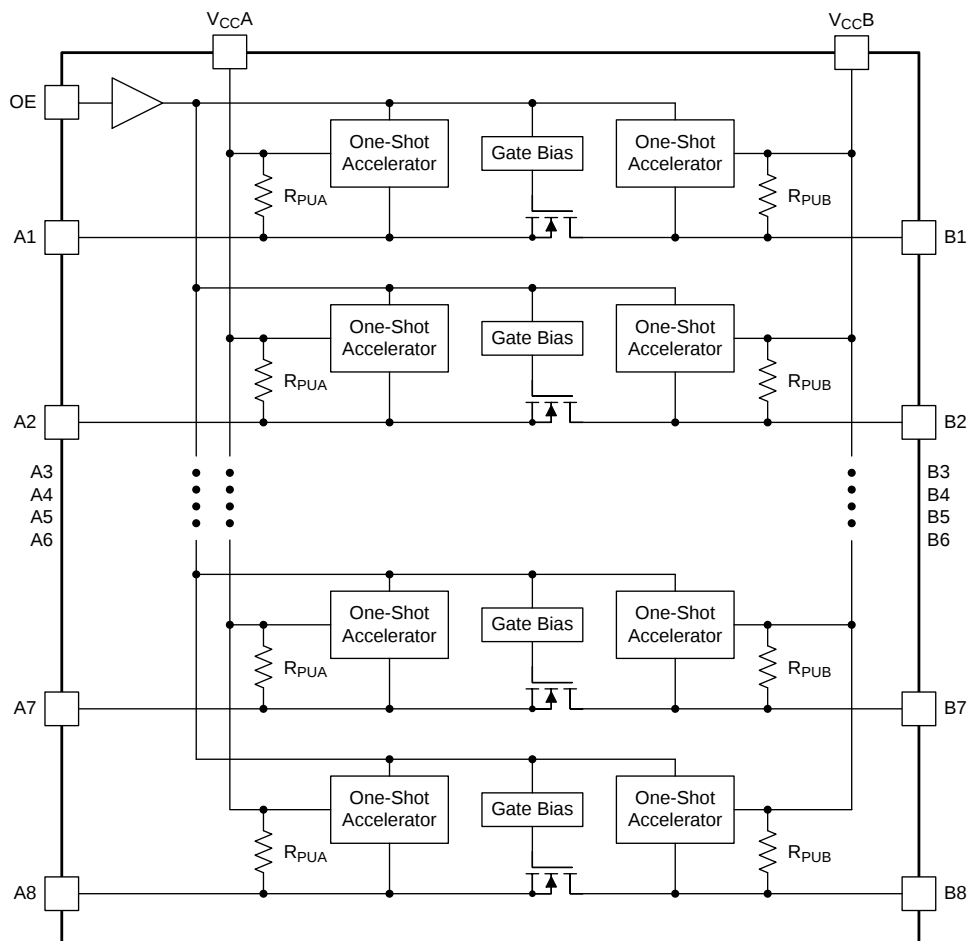
Figure 10. Enable and Disable Times

8 Detailed Description

8.1 Overview

The TXS0108E-Q1 device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A-port accepts I/O voltages ranging from 1.4 V to 3.6 V. The B-port accepts I/O voltages from 1.65 V to 5.5 V. The device uses pass gate architecture with edge rate accelerators (one shots) to improve the overall data rate. The pull-up resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

8.2 Functional Block Diagram



Each A-port I/O has a pull-up resistor (R_{PUA}) to V_{CCA} and each B-port I/O has a pull-up resistor (R_{PUB}) to V_{CCB} . R_{PUA} and R_{PUB} have a value of 40 k Ω when the output is driving low. R_{PUA} and R_{PUB} have a value of 4 k Ω when the output is driving high. R_{PUA} and R_{PUB} are disabled when OE = Low.

8.3 Feature Description

8.3.1 Architecture

Figure 11 describes semi-buffered architecture design this application requires for both push-pull and open-drain mode. This application uses edge-rate accelerator circuitry (for both the high-to-low and low-to-high edges), a high-on-resistance N-channel pass-gate transistor (on the order of 300 Ω to 500 Ω) and pull-up resistors (to provide DC-bias and drive capabilities) to meet these requirements. This design needs no direction-control signal (to control the direction of data flow from A to B or from B to A). The resulting implementation supports both low-speed open-drain operation as well as high-speed push-pull operation.

Feature Description (continued)

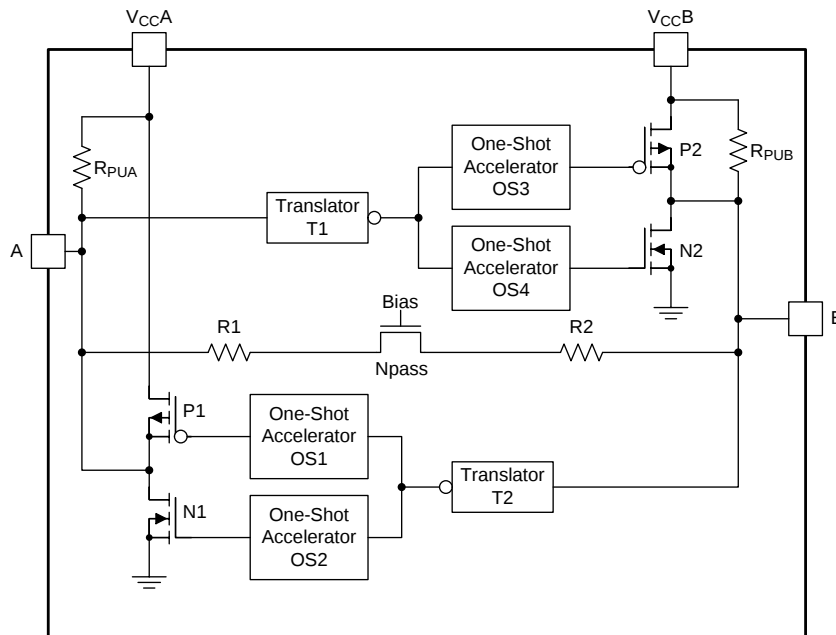


Figure 11. Architecture of a TXS0108E-Q1 Cell

When transmitting data from A-ports to B-ports, during a rising edge the one-shot circuit (OS3) turns on the PMOS transistor (P2) for a short-duration which reduces the low-to-high transition time. Similarly, during a falling edge, when transmitting data from A to B, the one-shot circuit (OS4) turns on the N-channel MOSFET transistor (N2) for a short-duration which speeds up the high-to-low transition. The B-port edge-rate accelerator consists of one-shot circuits OS3 and OS4. Transistors P2 and N2 and serves to rapidly force the B port high or low when a corresponding transition is detected on the A port.

When transmitting data from B- to A-ports, during a rising edge the one-shot circuit (OS1) turns on the PMOS transistor (P1) for a short-duration which reduces the low-to-high transition time. Similarly, during a falling edge, when transmitting data from B to A, the one-shot circuit (OS2) turns on NMOS transistor (N1) for a short-duration and this speeds up the high-to-low transition. The A-port edge-rate accelerator consists of one-shots OS1 and OS2, transistors P1 and N1 components and form the edge-rate accelerator and serves to rapidly force the A port high or low when a corresponding transition is detected on the B port.

8.3.2 Input Driver Requirements

The continuous DC-current *sinking* capability is determined by the external system-level open-drain (or push-pull) drivers that are interfaced to the TXS0108E-Q1 I/O pins. Because the high bandwidth of these bidirectional I/O circuits is used to facilitate this fast change from an input to an output and an output to an input, they have a modest DC-current *sourcing* capability of hundreds of micro-amperes, as determined by the internal pull-up resistors.

The fall time (t_{fA} , t_{fB}) of a signal depends on the edge-rate and output impedance of the external device driving TXS0108E-Q1 data I/Os, as well as the capacitive loading on the data lines.

Similarly, the t_{PHL} and maximum data rates also depend on the output impedance of the external driver. The values for t_{fA} , t_{fB} , t_{PHL} , and maximum data rates in the data sheet assume that the output impedance of the external driver is less than 50 Ω .

Feature Description (continued)

8.3.3 Output Load Considerations

TI recommends careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper one-shot triggering takes place. PCB signal trace-lengths should be kept short enough such that the round trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The one-shot circuits have been designed to stay on for approximately 30 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The one-shot duration has been set to best optimize trade-offs between dynamic I_{CC} , load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance of the TXS0108E-Q1 output. Therefore, TI recommends that this lumped-load capacitance is considered in order to avoid one-shot retriggering, bus contention, output signal oscillations, or other adverse system-level affects.

8.3.4 Enable and Disable

The TXS0108E-Q1 has an OE pin input that is used to disable the device by setting the OE pin low, which places all I/Os in the Hi-Z state. The disable time (t_{dis}) indicates the delay between the time when the OE pin goes low and when the outputs actually get disabled (Hi-Z). The enable time (t_{en}) indicates the amount of time the design must allow for the one-shot circuitry to become operational after the OE pin goes high.

8.3.5 Pull-up or Pull-down Resistors on I/O Lines

The TXS0108E-Q1 has the smart pull-up resistors dynamically change value based on whether a low or a high is being passed through the I/O line. Each A-port I/O has a pull-up resistor (R_{PUA}) to V_{CCA} and each B-port I/O has a pull-up resistor (R_{PUB}) to V_{CCB} . R_{PUA} and R_{PUB} have a value of 40 k Ω when the output is driving low. R_{PUA} and R_{PUB} have a value of 4 k Ω when the output is driving high. R_{PUA} and R_{PUB} are disabled when OE = Low. This feature provides lower static power consumption (when the I/Os are passing a low), and supports lower V_{OL} values for the same size pass-gate transistor, and helps improve simultaneous switching performance.

8.4 Device Functional Modes

The TXS0108E-Q1 device has two functional modes, enabled and disabled. To disable the device set the OE pin input low, which places all I/Os in a high impedance state. Setting the OE pin input high enables the device.

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TXS0108E-Q1 can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The device is ideal for use in applications where an open-drain driver is connected to the data I/Os. The device is appropriate for applications where a push-pull driver is connected to the data I/Os, but the TXB0104 device, (SCES650) *4-Bit Bidirectional Voltage-Level Translator* might be a better option for such push-pull applications. The device is a semi-buffered auto-direction-sensing voltage translator design is optimized for translation applications (for example, MMC Card Interfaces) that require the system to start out in a low-speed open-drain mode and then switch to a higher speed push-pull mode.

9.2 Typical Application

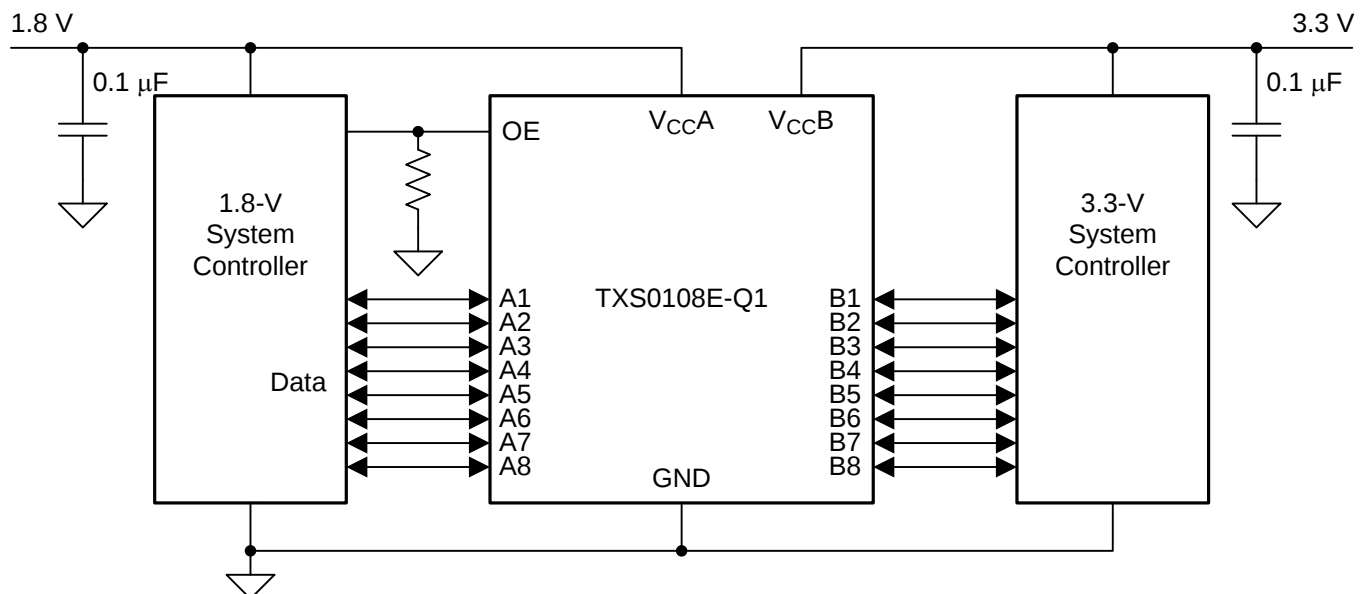


Figure 12. Typical Application Circuit

9.2.1 Design Requirements

For this design example, use the parameters listed in Table 1. Ensure that $V_{CCA} \leq V_{CCB}$.

Table 1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	1.4 V to 3.6 V
Output voltage range	1.65 V to 5.5 V

9.2.2 Detailed Design Procedure

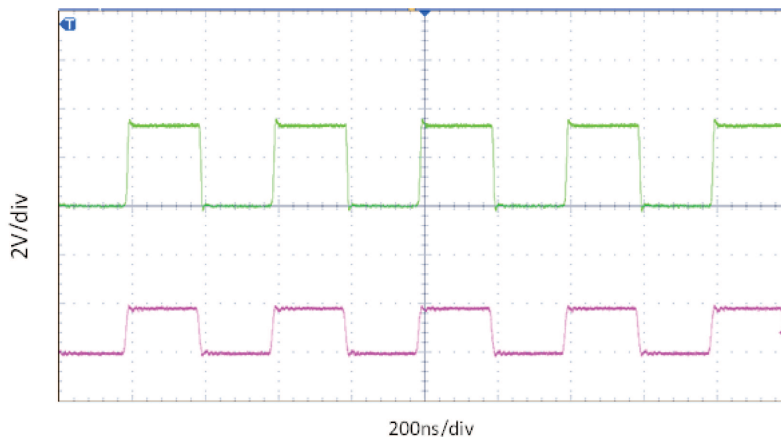
To begin the design process, determine the following:

- Input voltage range
 - Use the supply voltage of the device that is driving the TXS0108E-Q1 device to determine the input voltage range. For a valid logic high the value must exceed the V_{IH} of the input port. For a valid logic low the value must be less than the V_{IL} of the input port.

- Output voltage range
 - Use the supply voltage of the device that the TXS0108E-Q1 device is driving to determine the output voltage range.
 - The TXS0108E-Q1 device has smart internal pull-up resistors. External pull-up resistors can be added to reduce the total RC of a signal trace if necessary.
- An external pull-down resistor decreases the output VOH and VOL. Use [Equation 1](#) to calculate the VOH as a result of an external pull-down resistor.

$$V_{OH} = V_{CCX} \times R_{PD} / (R_{PD} + 4 \text{ k}\Omega) \quad (1)$$

9.2.3 Application Curves



$$V_{CCA} = 1.8 \text{ V}$$

$$V_{CCB} = 3.3 \text{ V}$$

Figure 13. Level-Translation of a 2.5-MHz Signal

10 Power Supply Recommendations

During operation, ensure that $V_{CCA} \leq V_{CCB}$ at all times. The sequencing of each power supply will not damage the device during the power up operation, so either power supply can be ramped up first. The output-enable (OE) input circuit is designed so that it is supplied by V_{CCA} and when the (OE) input is low, all outputs are placed in the high-impedance state. To ensure the high-impedance state of the outputs during power up or power down, the OE input pin must be tied to GND through a pull-down resistor and must not be enabled until V_{CCA} and V_{CCB} are fully ramped and stable. The minimum value of the pull-down resistor to ground is determined by the current-sourcing capability of the driver.

11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines is recommended.

- Bypass capacitors should be used on power supplies. Place the capacitors as close as possible to the V_{CCA} , V_{CCB} pin and GND pin.
- Short trace lengths should be used to avoid excessive loading.
- PCB signal trace-lengths must be kept short enough so that the round-trip delay of any reflection is less than the one shot duration, approximately 30 ns, ensuring that any reflection encounters low impedance at the source driver.

11.2 Layout Example

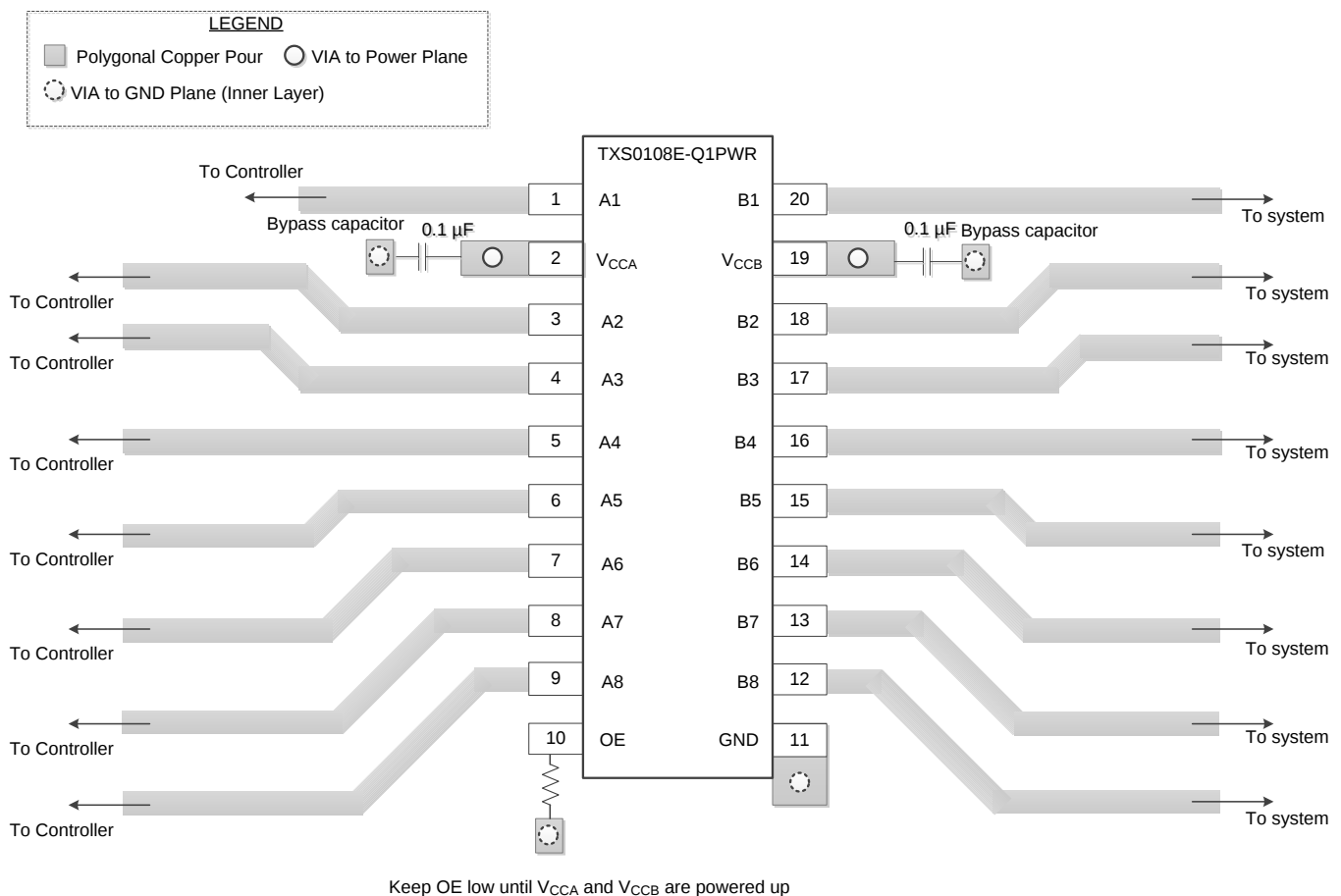


Figure 14. Layout Example

12 器件和文档支持

12.1 社区资源

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12.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本文档进行修订的情况下发生改变。欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TXS0108EQPWRQ1	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	YF08EQ1	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TXS0108EQPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

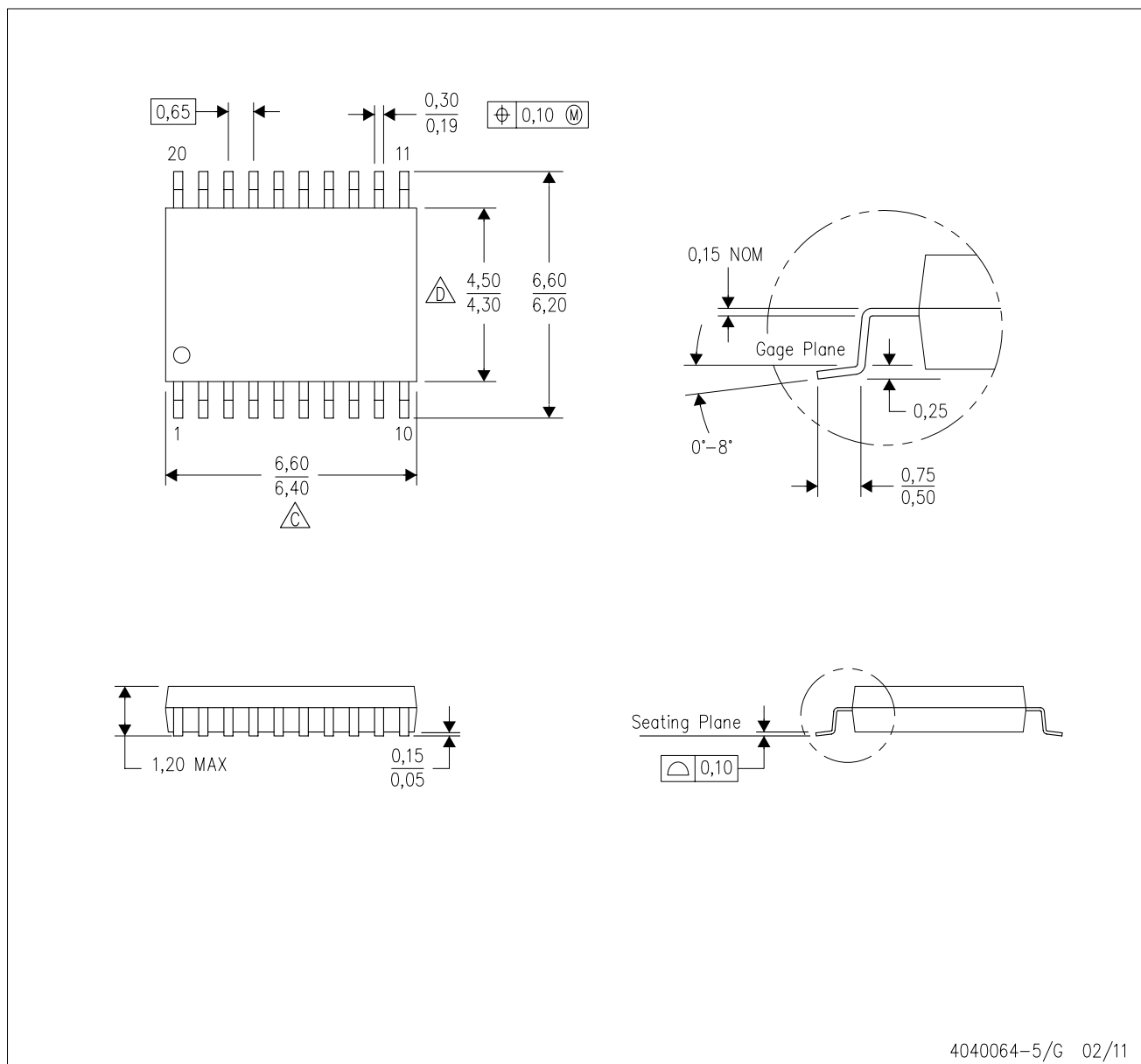


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TXS0108EQPWRQ1	TSSOP	PW	20	2000	853.0	449.0	35.0

PW (R-PDSO-G20)

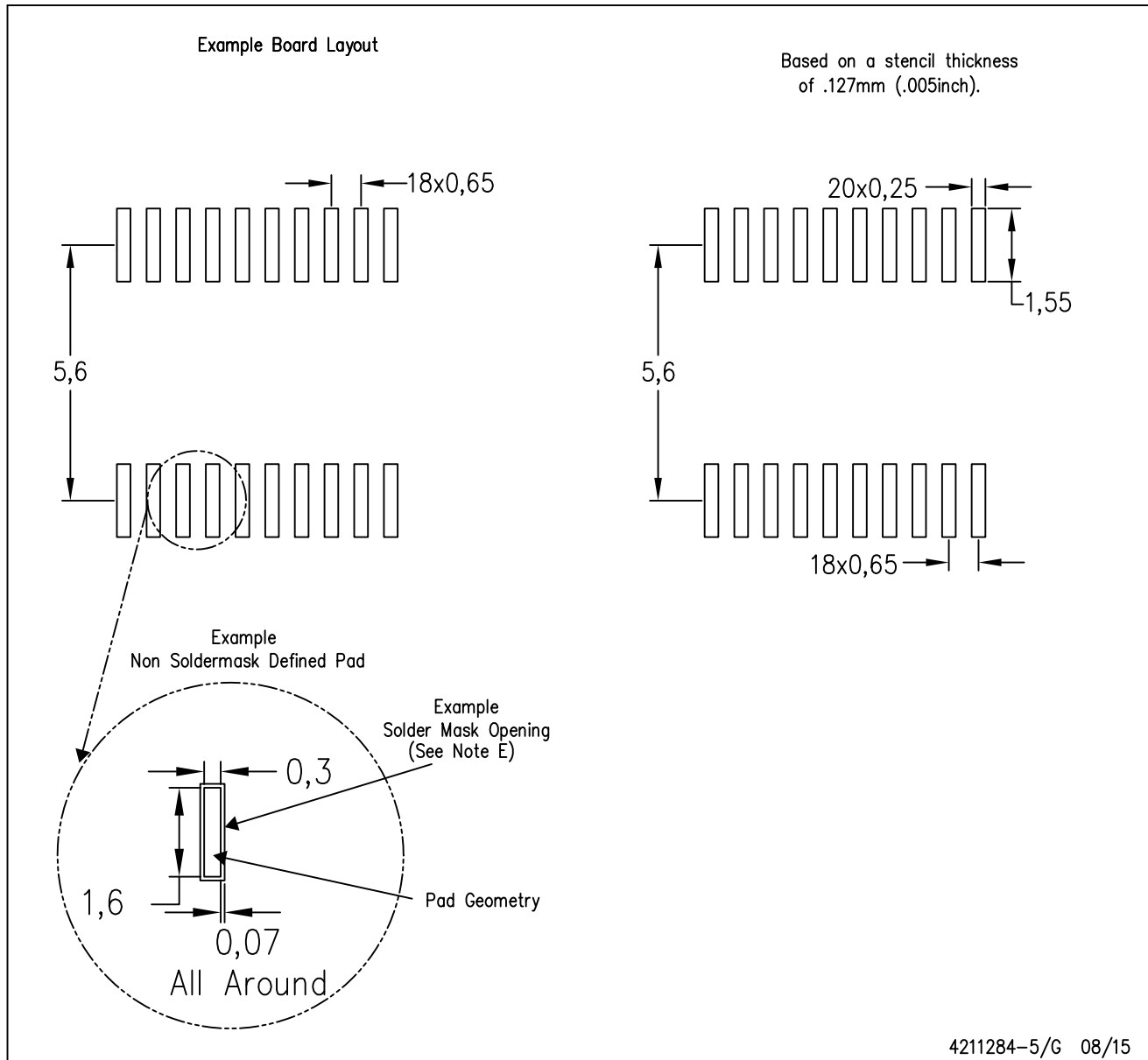
PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate design.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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